

<b>Search Notes</b> 	<b>Application/Control No.</b>  <b>10/786,372</b>	<b>Applicant(s)/Patent under Reexamination</b>  <b>ZHENG ET AL.</b>
	<b>Examiner</b>  <b>Dawn Garrett</b>	<b>Art Unit</b>  <b>1774</b>

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST SEARCH - Databases: JPO EPO DERWENT USPGPUB'USPAT Text, classification and classification limited by text searching <i>see printout</i>	7/31/2005	Def
STIC search report attached	4/22/2005	Def
STIC search report attached	6/24/2005	Def
Inventor name search: PALM, EAST, eDAN	7/2005	Def
EAST search <i>(see printout)</i>	1/9/06	Def
EAST search <i>(see printout)</i>	8/29/06	Def
STIC search <i>(see printout)</i>	8/2/06	Def